## Phase field modeling on initial microstructure effect on grain coarsening and concomitant property degradation in SOFC electrodes

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#### Purpose of this research:

- · Simulate microstructure evolution and concomitant property degradation in SOFC electrodes.
- Link attributes of initial microstructure to the rate of property degradation in SOFC electrodes.

### Coarsening in SOFC electrodes:

- Driven by the interface curvature of particles/grains in different sizes.
- Leads to loss of TPB density, specific surface area and effective conductivity in both anode and cathode [1,2].

# Phase field modeling

- Capable of simulating long term microstructure evolution.
- Properties of electrode can be extracted directly from simulated microstructures.
- The interfacial energy in our recently developed phase field model [1] can be easily tuned to match the interfacial energy of the real materials, i.e. Ni-YSZ for anode and LSM-YSZ for cathode.
- The mobility is tuned to match the self-diffusivity of Ni and LSM in bulk, while YSZ is kept static due to its slow self-diffusion.



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with increased average grain size of Ni/LSM.

[2] Zekri et al, Phys Chem Chem Phys, (2017), doi: 10.1039/C7CP02186K



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SSA of Ni

 $\sigma_{eff}(x)$ 

0.0

0.15 0.20